

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination HAHN ET AL.	
		Examiner Robert Shiao	Art Unit 1626	Page 1 of 3

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
<input checked="" type="checkbox"/>	U	Pokrovskaya et al., 1960, CAS:55:142216.
<input checked="" type="checkbox"/>	V	Van Dormael et al., 1958, CAS:54:26887.
<input checked="" type="checkbox"/>	W	Carroll, 1957,CAS:51:70442.
<input checked="" type="checkbox"/>	X	Shiba et al., 1971, CAS:74:36922.

<sup>1</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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<b>Notice of References Cited</b>		Application/Control No. 09/839,577	Applicant(s)/Patent Under Reexamination HAHN ET AL.	
		Examiner Robert Shiao	Art Unit 1626	Page 2 of 3

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	09/839,577	HAHN ET AL.	
Examiner	Art Unit	Robert Shiao	Page 3 of 3

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